Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/780,673	HAN, JONG-HEE	
Examiner	Art Unit	
Vivek Srivastava	2611	

SEARCHED				
Class	Subclass	Date	Examiner	
725	25-31	3/4/2005	vs	
380	205, 206	3/4/2005	VS	
380	210-213	3/4/2005	vs	
380	221	3/4/2005	vs	
348	528	3/4/2005	vs	
			,	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	-			
				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
		DATE	EXMR		
	·				